Features





Dual Quick-PWM, Step-Down Controller with Low-Power LDO, RTC Regulator

General Description

The MAX17101 is a dual Quick-PWM™ step-down power-supply (SMPS) controller with synchronous rectification, intended for main 5V/3.3V power generation in battery-powered systems. Low-side MOSFET sensing provides a simple low-cost, highly efficient current sense for providing valley current-limit protection. Combined with the output overvoltage and undervoltage protection features, this current limit ensures robust output supplies.

The 5V/3.3V SMPS outputs can save power by operating in pulse-skipping mode or in ultrasonic mode to avoid audible noise. Ultrasonic mode forces the controller to maintain switching frequencies greater than 20kHz at light loads.

An internal 100mA linear regulator can be used to either generate the 5V bias needed for power-up or other lower power "always-on" suspend supplies. An independent bypass input allows automatic bypassing of the linear regulator when the SMPS is active.

This main controller also includes a secondary feedback input that triggers an ultrasonic pulse (DL1 turned on) if the SECFB voltage drops below its threshold voltage. This refreshes an external charge pump driven by DL1 without overcharging the output voltage.

The device includes independent shutdown controls to simplify power-up and power-down sequencing. To prevent current surges at startup, the internal voltage target is slowly ramped up from zero to the final target over a 1ms period. To prevent the output from ringing below ground in shutdown, the internal voltage target is ramped down from its previous value to zero over a 1ms period. Two independent power-good outputs simplify the interface with external controllers.

The MAX17101 comes in a lead-free 32-pin TQFN (5mm x 5mm) package and operates in the -40°C to +85°C temperature range.

Applications

Notebook Computers

Main System Supply (5V and 3.3V Supplies)

Graphic Cards

DDR1, DDR2, DDR3 Power Supplies

Game Consoles

Low-Power I/O and Chipset Supplies

Two to Four Li+ Cells Battery-Powered Devices

PDAs and Mobile Communicators

Telecommunication

Quick-PWM is a trademark of Maxim Integrated Products, Inc.

♦ Dual Quick-PWM

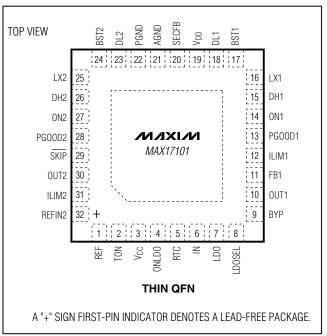
- ♦ Internal 100mA 5V or Adjustable Linear Regulator
- ♦ Independent LDO Bypass Input
- ♦ Internal Boost Diodes
- ♦ Secondary Feedback Input Maintains Charge Pump
- ♦ 3.3V 5mA RTC Power (Always On)
- ♦ OUT1: 5V or 1.5V Fixed or 0.7V Adjustable **Feedback**
- ♦ OUT2: 3.3V or 1.05V Fixed or Dynamic Adjustable
- ♦ Dynamic 0 to 2V REFIN2 Input on Second Output
- ♦ 2V ±1% 50µA Reference
- ♦ 6V to 24V Input Range (28V max)
- **♦ Ultrasonic Mode**
- ♦ Independent SMPS and LDO Enable Controls
- **♦ Independent SMPS Power-Good Outputs**
- **♦ Minimal Component Count**

Ordering Information

PART	TEMP RANGE	PIN-PACKAGE
MAX17101ETJ+	-40°C to +85°C	32 Thin QFN-EP*

⁺Denotes a lead-free/RoHS-compliant package.

Pin Configuration



^{*}EP = Exposed pad.

ABSOLUTE MAXIMUM RATINGS

IN, ONLDO to GND	0.3V to +6V 0.3V to +6V 0.3V to +6V 0.3V to (V _{CC} + 0.3V)	BST1 to LX1
REF, ILIM_, TON, SKIP to GND FB1, REFIN2, LDOSEL to GND		Continuous+100mA LDO Current (Switched Over) Continuous+200mA
SECFB to GND	0.3V to +6V	Continuous Power Dissipation (T _A = +70°C) 32-Pin 5mm x 5mm TQFN
GND to PGND		(derate 34.5mW/°C above +70°C)2.76W
DL_ to PGND		Operating Temperature Range40°C to +85°C
BST_ to GND		Junction Temperature+150°C
BST_ to V _{DD}		Storage Temperature Range65°C to +150°C
DH1 to LX1	0.3V to (V _{BST1} + 0.3V)	Lead Temperature (soldering, 10s)+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

(Circuit of Figure 1, no load on LDO, RTC, OUT1, OUT2, and REF, V_{IN} = 12V, V_{DD} = V_{CC} = V_{SECFB} = 5V, V_{REFIN2} = 1.0V, BYP = LDOSEL = GND, ONLDO = IN, ON1 = ON2 = V_{CC} , $T_A = 0^{\circ}C$ to +85°C, unless otherwise noted. Typical values are at $T_A = +25^{\circ}C$.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
INPUT SUPPLIES			•			
IN Standby Supply Current	I _{IN(STBY)}	V_{IN} = 6V to 24V, ON1 = ON2 = GND, ONLDO = V_{CC}		85	175	μΑ
IN Shutdown Supply Current	IN(SHDN)	V _{IN} = 4.5V to 24V, ON1 = ON2 = ONLDO = GND		50	70	μА
IN Supply Current	I _{IN}	$ON1 = ON2 = REFIN2 = V_{CC},$ $\overline{SKIP} = FB1 = GND,$ $V_{OUT2} = 3.5V, V_{OUT1} = 5.3V$		0.1	0.2	mA
V _{CC} Supply Current	Icc	$ON1 = ON2 = REFIN2 = V_{CC},$ $\overline{SKIP} = FB1 = GND,$ $V_{OUT2} = 3.5V, V_{OUT1} = 5.3V$		1.0	1.5	mA
PWM CONTROLLERS						
	V2.7.	5V preset output: FB1 = GND, V _{IN} = 12V, SKIP = V _{CC}	4.925	5.00	5.075	
OUT1 Output-Voltage Accuracy (Note 1)	VOUT1	1.5V preset output: FB1 = V _{CC} (5V), V _{IN} = 12V, SKIP = V _{CC}	1.482	1.50	1.518	V
	V _{FB1}	Adjustable feedback output, V _{IN} = 12V, SKIP = V _{CC}	0.690	0.700	0.710	
OUT1 Voltage-Adjust Range			0.7		5.5	V
ED1 Dual Mada IM Threak - ! -!		Low	0.04		0.110	
FB1 Dual Mode™ Threshold Voltage LeveIs		High	V _{CC} - 1.6V		V _{CC} - 0.7V	V
FB1 Input Bias Current	I _{FB1}	V _{FB1} = 0.8V, T _A = +25°C	-0.2		+0.2	μΑ

Dual Mode is a trademark of Maxim Integrated Products, Inc.

ELECTRICAL CHARACTERISTICS (continued)

(Circuit of Figure 1, no load on LDO, RTC, OUT1, OUT2, and REF, $V_{IN} = 12V$, $V_{DD} = V_{CC} = V_{SECFB} = 5V$, $V_{REFIN2} = 1.0V$, BYP = LDOSEL = GND, ONLDO = IN, ON1 = ON2 = V_{CC} , $V_{$

PARAMETER	SYMBOL	COI	NDITIONS	MIN	TYP	MAX	UNITS
		3.3V preset output: V _{IN} = 12V, SKIP = V		3.255	3.30	3.345	
OUT2 Output-Voltage Accuracy (Note 1)	V _{OUT2}	1.05V preset output V _{IN} = 12V, SKIP = V	: REFIN2 = RTC (3.3V), 'CC	1.038	1.050	1.062	V
		Tracking output: V _R V _{IN} = 12V, SKIP = V		1.09	1.10	1.11	
OUT2 Voltage-Adjust Range				0.8		2.0	V
REFIN2 Voltage-Adjust Range				0		2	V
DECING Input Dies Current	la seu va	VREFIN2 = 2.2V, TA :	= +25°C	-0.1		+0.1	
REFIN2 Input Bias Current	REFIN2	V _{REFIN2} = 0V, T _A =	+25°C	-0.5		+0.1	- μΑ
REFIN2 Dual Mode Threshold		Low (REFIN2 = RTC	C)	2.2		3.0	
Voltage Levels		High (REFIN2 = V _{CC}	c)	V _{CC} - 1.0V		V _{CC} - 0.4V	\ V
		Either SMPS, SKIP =	= V _{CC} , I _{LOAD} = 0 to 5A		-0.1		
Load Regulation Error		Either SMPS, SKIP =	Either SMPS, SKIP = REF, I _{LOAD} = 0 to 5A		-1.7		%
		Either SMPS, SKIP = GND, I _{LOAD} = 0 to 5A			-1.5		1
Line Regulation Error		Either SMPS, V _{IN} = 6	6V to 24V		0.005		%/V
DH1 On-Time	ton1	V _{IN} = 12V, V _{OUT1} = 5.0V	TON = GND or REF (400kHz)	895	1052	1209	ns
		(Note 2)	TON = V _{CC} (200kHz)		2105		
		V _{IN} = 12V,	TON = GND (500kHz)		555		
DH2 On-Time	t _{ON2}	V _{OUT2} = 3.3V (Note 2)	TON = REF or V _{CC} (300kHz)	833	925	1017	ns
Minimum Off-Time	toff(MIN)	(Note 2)			300	400	ns
Soft-Start/Stop Slew Rate	tss	Rising/falling edge	on ON1 or ON2 (preset)		1		ms
Soft-Start/Stop Slew Rate	tss	Rising/falling edge	on ON2 (REFIN2 ADJ)		1		mV/μs
Dynamic REFIN2 Slew Rate	t _{DYN}	Rising edge on REF	FIN2		8		mV/μs
Ultrasonic Operating Frequency	fsw(usonic)	SKIP = open (REF)		20	27		kHz
SECFB Threshold Voltage	VSECFB			1.94	2.0	2.06	V
SECFB Input Bias Current	ISECFB	VSECFB = 2.2V, TA =	= +25°C	-0.2		+0.2	μΑ
LINEAR REGULATOR (LDO)							
LDO Output Voltage Acquirecy	\/, = 0	V _{IN} = 24V, LDOSEL 0 < I _{LDO} < 100mA	= BYP = GND,	4.90	5.0	5.10	V
LDO Output-Voltage Accuracy	V _{LDO}	V _{IN} = 24V, LDOSEL = V _{CC} , BYP = GND, 0 < I _{LDO} < 100mA		3.23	3.3	3.37	V
LDOSEL Dual Made Threshold		LDOSEL low		0.1	0.15	0.2	
LDOSEL Dual Mode Threshold Voltage Levels		LDOSEL high		V _{CC} - 0.9V			V

ELECTRICAL CHARACTERISTICS (continued)

(Circuit of Figure 1, no load on LDO, RTC, OUT1, OUT2, and REF, $V_{IN} = 12V$, $V_{DD} = V_{CC} = V_{SECFB} = 5V$, $V_{REFIN2} = 1.0V$, BYP = LDOSEL = GND, ONLDO = IN, ON1 = ON2 = V_{CC} , $T_A = 0^{\circ}C$ to +85°C, unless otherwise noted. Typical values are at $T_A = +25^{\circ}C$.)

PARAMETER	PARAMETER SYMBOL CONDITIONS		MIN	TYP	MAX	UNITS
LDO Short-Circuit Current	lilim(LDO)	LDO = GND	100		260	mA
LDO Regulation Reduction/ Bypass Switchover Threshold		With respect to the LDO voltage, falling edge of BYP	-11.0	-8.5	-6.0	%
LDO Bypass Switchover Threshold		With respect to the LDO voltage, rising edge of BYP		-6.5		%
LDO Bypass Switchover Startup Timeout	t _{BYP}	Rising edge of BYP to bypass gate pulled low		500		μs
LDO Bypass Switch Resistance		LDO to BYP, V _{BYP} = 5V (Note 4)		1.2	4.5	Ω
VCC Undervoltage-Lockout (UVLO) Threshold	Vuvlo(vcc)	Falling edge of V _{CC} , PWM disabled below this threshold	3.8	4.0	4.3	V
(GVEG) This contoin		Rising edge of V _{CC}		4.2		
Thermal-Shutdown Threshold	TSHDN	Hysteresis = 10°C		+160		°C
3.3V ALWAYS-ON LINEAR REG	ULATOR (RT	C)				
DTC Output Voltage Acquirecy	\/p0	ON1 = ON2 = GND, V _{IN} = 6V to 24V, 0 < I _{RTC} < 5mA	3.23	3.33	3.43	V
RTC Output-Voltage Accuracy	VRTC	ON1 = ON2 = ONLDO = GND, V _{IN} = 6V to 24V, 0 < I _{RTC} < 5mA	3.16		3.50	V
RTC Short-Circuit Current	ILIM(RTC)	RTC = GND	5			mA
REFERENCE (REF)			•			
Reference Voltage	V _{REF}	V _{CC} = 4.5V to 5.5V, I _{REF} = 0	1.980	2.00	2.020	V
Reference Load Regulation	V _{REF}	I _{REF} = -20μA to +50μA	-10		+10	mV
REF Lockout Voltage	VREF(UVLO)	Rising edge, 350mV (typ) hysteresis		1.95		V
OUT1 FAULT DETECTION						
OUT1 Overvoltage Trip Threshold	VOVP(OUT1)	With respect to error-comparator threshold	12	16	20	%
OUT1 Overvoltage Fault-Propagation Delay	tovp	FB1 forced 50mV above trip threshold		10		μs
OUT1 Undervoltage Protection Trip Threshold	Vuvp(out1)	With respect to error-comparator threshold	65	70	75	%
OUT1 Output-Undervoltage Fault-Propagation Delay	tuvp			10		μs
PGOOD1 Lower Trip Threshold		With respect to error-comparator threshold, falling edge, hysteresis = 1%	-20	-16	-12	%
PGOOD1 Propagation Delay	tPGOOD1	FB1 forced 50mV beyond PGOOD1 trip threshold, falling edge		10		μs
PGOOD1 Output Low Voltage		V _{FB1} = 0.56V (PGOOD1 low impedance), I _{SINK} = 4mA			0.3	V
PGOOD1 Leakage Current	IPGOOD1	V _{FB1} = 0.70V (PGOOD1 high impedance), PGOOD1 forced to 5.5V			1	μΑ

ELECTRICAL CHARACTERISTICS (continued)

(Circuit of Figure 1, no load on LDO, RTC, OUT1, OUT2, and REF, $V_{IN} = 12V$, $V_{DD} = V_{CC} = V_{SECFB} = 5V$, $V_{REFIN2} = 1.0V$, BYP = LDOSEL = GND, ONLDO = IN, ON1 = ON2 = V_{CC} , $V_{$

PARAMETER	SYMBOL	CON	IDITIONS	MIN	TYP	MAX	UNITS
OUT2 FAULT DETECTION		1					
OUT2 Overvoltage Trip	\/	With respect to error	-comparator threshold	12	16	20	%
Threshold	Vovp(out2)	Minimum overvoltag	ge threshold		0.7		V
OUT2 Overvoltage Fault-Propagation Delay	tovp	OUT2 forced 50mV a	above trip threshold		10		μs
OUT2 Undervoltage Protection Trip Threshold	Vuvp(OUT2)	With respect to error-	-comparator threshold	65	70	75	%
OUT2 Overvoltage Fault-Propagation Delay	tovp	OUT2 forced 50mV a	above trip threshold		10		μs
OUT2 Output Undervoltage Fault-Propagation Delay	tuvp	OUT2 forced 50mV b	elow trip threshold		10		μs
PGOOD2 Lower Trip Threshold		With respect to error- falling edge, hystere	comparator threshold, sis = 2%	-20	-16	-12	%
PGOOD2 Propagation Delay	tpgood_	OUT2 forced 50mV by threshold, falling ed	•		10		μs
PGOOD2 Output-Low Voltage		V _{OUT2} = V _{REFIN2} - 15 impedance), I _{SINK} =	,			0.3	V
PGOOD2 Leakage Current	IPGOOD_	OUT2 = REFIN2 (PG PGOOD2 forced to 5	OOD2 high impedance), $.5V$, $T_A = +25^{\circ}C$			1	μА
CURRENT LIMIT	•						
ILIM_ Adjustment Range	VILIM			0.2		2.0	V
ILIM_ Current	lilim				5		μΑ
Valley Current-Limit Threshold	VVALLEY	VAGND - VLX_	$R_{ILIM} = 100k\Omega$	40	50	60	mV
(Adjustable)	VALLET	VAGIND VLA	$R_{ILIM} = 200k\Omega$	87	100	113	1111
Current-Limit Threshold (Negative)	VNEG	With respect to valley current-limit threshold, SKIP = VCC			-120		%
Ultrasonic Current-Limit Threshold	VNEG(US)	V _{OUT1} = V _{OUT2} = V _{FB1} = 0.77V, V _{REFIN2} = 0.70V			25		mV
Current-Limit Threshold (Zero Crossing)	V _Z X	V _{AGND} - V _{LX} , SKIP = GND or OPEN/REF			1		mV

ELECTRICAL CHARACTERISTICS (continued)

(Circuit of Figure 1, no load on LDO, RTC, OUT1, OUT2, and REF, $V_{IN} = 12V$, $V_{DD} = V_{CC} = V_{SECFB} = 5V$, $V_{REFIN2} = 1.0V$, BYP = LDOSEL = GND, ONLDO = IN, ON1 = ON2 = V_{CC} , $V_{$

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
GATE DRIVERS			•			
DH_ Gate Driver On-Resistance	R _{DH}	BST1 - LX1 and BST2 - LX2 forced to 5V		1.5	3.5	Ω
DL Gate Driver On-Resistance	Dou	DL1, DL2; high state		2.2	4.5	Ω
DL_Gale Driver On-Resistance	R _{DL}	DL1, DL2; low state		0.6	1.5	1 12
DH_ Gate Driver Source/Sink Current	IDH	DH1, DH2 forced to 2.5V, BST1 - LX1 and BST2 - LX2 forced to 5V		2		А
DL_ Gate Driver Source Current	I _{DL} (SOURCE)	DL1, DL2 forced to 2.5V		1.7		А
DL_ Gate Driver Sink Current	IDL (SINK)	DL1, DL2 forced to 2.5V		3.3		А
Internal BST_ Switch On-Resistance	R _{BST}	I _{BST} _ = 10mA, V _{DD} = 5V		5		Ω
INPUTS AND OUTPUTS	•		•			
		High	V _{CC} - 0.4V			
TON Input Logic Levels		REF or open	1.6		3.0] V
		Low			0.4]
		High (forced PWM)	V _{CC} - 0.4V			
SKIP Input Logic Levels		Open (ultrasonic)	1.6		3.0	\ \
		Low (SKIP)			0.4]
SKIP, TON Leakage Current	ISKIP, ITON	$V_{\overline{SKIP}} = V_{TON} = 0 \text{ or } 5V, T_A = +25^{\circ}C$	-2		+2	μΑ
		High (SMPS on)	2.4			.,,
ON_ Input Logic Levels		Low (SMPS off)			0.8	V
ON_ Leakage Current	I _{ON} _	V _{ON1} = V _{ON2} = 0 or 5V, T _A = +25°C	-2		+2	μΑ
		High (SMPS on)	2.4			\
ONLDO Input Logic Levels		Low (SMPS off)			0.8	V
ONLDO Leakage Current	IONLDO	V _{ONLDO} = 0 or 24V, T _A = +25°C	-1		+1	μΑ

ELECTRICAL CHARACTERISTICS

(Circuit of Figure 1, no load on LDO, RTC, OUT1, OUT2, and REF, V_{IN} = 12V, V_{DD} = V_{CC} = V_{SECFB} = 5V, V_{REFIN2} = 1.0V, BYP = LDOSEL = GND, ONLDO = IN, ON1 = ON2 = V_{CC} , V_{CC} ,

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS	
INPUT SUPPLIES								
IN Standby Supply Current	lin(STBY)	V _{IN} = 6V to 24V, ON1 = ONLDO = V _{CC}	V_{IN} = 6V to 24V, ON1 = ON2 = GND, ONLDO = V_{CC}			200	μА	
IN Shutdown Supply Current	IN(SHDN)	V _{IN} = 4.5V to 24V, ON1 =	ON2 = ONLDO = GND			70	μΑ	
IN Supply Current	I _{IN}	ON1 = ON2 = REFIN2 SKIP = FB1 = GND, V _{OU}				0.2	mA	
V _{CC} Supply Current	Icc	ON1 = ON2 = REFIN2 SKIP = FB1 = GND, V _{OL}				1.5	mA	
PWM CONTROLLERS								
	Volume	5V preset output: FB1 : V _{IN} = 12V, SKIP = V _{CC}	= GND,	4.90		5.10		
OUT1 Output-Voltage Accuracy (Note 1)	Vout1	1.5V preset output: FB VIN = 12V, SKIP = VCC	$1 = V_{CC} (5V),$	1.47		1.53	\ \ \ \	
	V _{FB1}	Adjustable feedback o VIN = 12V, SKIP = VCC	utput,	0.685		0.715		
OUT1 Voltage-Adjust Range				0.7		5.5	V	
FB1 Dual Mode Threshold		Low		0.040		0.125		
Voltage		High		V _{CC} - 1.6V		V _{CC} - 0.7V	V	
		3.3V preset output: REF 12V, SKIP = V _{CC}	$FIN2 = V_{CC} (5V), V_{IN} =$	3.234		3.366		
OUT2 Output-Voltage Accuracy (Note 1)	V _{OUT2}	1.05V preset output: REVIN = 1.2V, SKIP = VCC		1.029		1.071	71 V	
		Tracking output: V _{REFII} V _{IN} = 12V, SKIP = V _{CC}	N2 = 1.1V,	1.085		1.115		
OUT2 Voltage-Adjust Range				0		2	V	
REFIN2 Voltage-Adjust Range				0		2	V	
REFIN2 Dual Mode Threshold		Low (REFIN2 = RTC)		2.2		3.0]	
Voltage		High (REFIN2 = V _{CC})		V _{CC} - 1.2V		V _{CC} - 0.4V	V	
DU1 On Time	torri	V _{IN} = 12V,	TON = GND or REF (400kHz)	895		1209		
DH1 On-Time	ton1	V _{OUT1} = 5.0V (Note 2)	TON = REF or V _{CC} (300kHz)	833		1017	ns	
Minimum Off-Time	toff(MIN)	(Note 2)				450	ns	
SECFB Threshold Voltage	VSECFB			1.92		2.08	V	

ELECTRICAL CHARACTERISTICS (continued)

(Circuit of Figure 1, no load on LDO, RTC, OUT1, OUT2, and REF, $V_{IN} = 12V$, $V_{DD} = V_{CC} = V_{SECFB} = 5V$, $V_{REFIN2} = 1.0V$, BYP = LDOSEL = GND, ONLDO = IN, ON1 = ON2 = V_{CC} , $V_{$

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
LINEAR REGULATOR (LDO)	•		•			
LDO Output-Voltage Accuracy	VLDO	$V_{IN} = 24V$, LDOSEL = BYP = GND, 0 < I_{LDO} < 100mA	4.85		5.15	V
LDO Output-Voltage Accuracy	VLDO	$V_{IN} = 24V$, LDOSEL = V_{CC} , BYP = GND, 0 < I_{LDO} < 100mA	3.20		3.40	V
LDOSEL Dual Mode		LDOSEL low			0.25	
Voltage Level		LDOSEL high	V _{CC} - 0.9V			V
LDO Short-Circuit Current	lilim(LDO)	LDO = GND			260	mA
LDO Regulation Reduction/ Bypass Switchover Threshold		Falling edge of BYP	-12		-5	%
V _{CC} Undervoltage-Lockout Threshold	Vuvlo(vcc)	Falling edge of V _{CC} , PWM disabled below this threshold	3.8		4.3	V
3.3V ALWAYS-ON LINEAR REG	ULATOR (RT	C)				
DTC Outrout Voltage Aggurgay	\/	ON1 = ON2 = GND, V_{IN} = 6V to 24V, $0 < I_{RTC} < 5$ mA	3.18		3.45	V
RTC Output-Voltage Accuracy	VRTC	ON1 = ON2 = ONLDO = GND, V _{IN} = 6V to 24V, 0 < I _{RTC} < 5mA	3.16		3.50	V
RTC Short-Circuit Current	liLiM(RTC)	RTC = GND	5			mA
REFERENCE (REF)						
Reference Voltage	V _{REF}	$V_{CC} = 4.5V \text{ to } 5.5V, I_{REF} = 0$	1.975		2.025	V
Reference Load-Regulation Error	ΔV_{REF}	I _{REF} = -20μA to +50μA	-10		+10	mV
OUT1 FAULT DETECTION						
OUT1 Overvoltage Trip Threshold	VovP(out1)	With respect to error-comparator threshold	10		20	%
OUT1 Undervoltage-Protection Trip Threshold	VUVP(OUT1)	With respect to error-comparator threshold	60		80	%
PGOOD1 Lower Trip Threshold		With respect to error-comparator threshold, falling edge, hysteresis = 1%	-20		-10	%
PGOOD1 Output-Low Voltage		V _{FB1} = 0.56V (PGOOD1 low impedance), I _{SINK} = 4mA			0.4	V
OUT2 FAULT DETECTION						
OUT2 Overvoltage Trip Threshold	Vovp(out2)	With respect to error-comparator threshold	10		20	%

ELECTRICAL CHARACTERISTICS (continued)

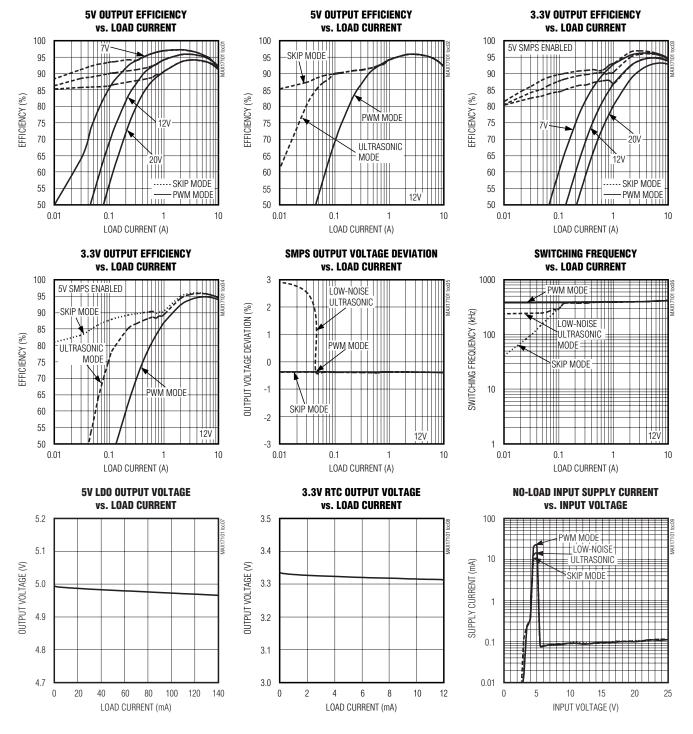
(Circuit of Figure 1, no load on LDO, RTC, OUT1, OUT2, and REF, $V_{IN} = 12V$, $V_{DD} = V_{CC} = V_{SECFB} = 5V$, $V_{REFIN2} = 1.0V$, BYP = LDOSEL = GND, ONLDO = IN, ON1 = ON2 = V_{CC} , $V_{$

PARAMETER	SYMBOL	CON	NDITIONS	MIN	TYP	MAX	UNITS
OUT2 Undervoltage-Protection Trip Threshold	Vuvp(OUT2)	With respect to error	r-comparator threshold	60		80	%
PGOOD2 Lower Trip Threshold		With respect to error falling edge, hystere	r-comparator threshold, esis = 2%	-20		-10	%
PGOOD2 Output-Low Voltage		V _{OUT2} = V _{REFIN2} - 15 impedance), I _{SINK} =	•			0.4	V
CURRENT LIMIT		I		·			
ILIM_ Adjustment Range	VILIM			0.2		2.0	V
Valley Current-Limit Threshold	\/	VAGND - VLX_	$R_{ILIM} = 100k\Omega$	40		60	mV
(Adjustable)	VVALLEY	VAGND - VLX_	$R_{ILIM} = 200k\Omega$	85		115] ''''
GATE DRIVERS							
DH_ Gate Driver On-Resistance	R _{DH}	BST1 - LX1 and BST	2 - LX2 forced to 5V			3.5	Ω
DL Gate Driver On-Resistance	R _{DL}	DL1, DL2; high state				4.5	Ω
DL_ date briver on-nesistance	LIDE	DL1, DL2; low state				1.5	52
INPUTS AND OUTPUTS							
TON leaves leaves leaves le		High		V _{CC} - 0.4V			
TON Input Logic Levels		REF or open		1.6		3.0	V
		Low				0.4	
		High (forced PWM)		V _{CC} - 0.4V			
SKIP Input Logic Levels		Open (ultrasonic)		1.6		3.0	V
		Low (skip)				0.4	
ON Input Legis Levels		High (SMPS on)		2.4			V
ON_ Input Logic Levels		Low (SMPS off)				0.8	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \
ONLDO Input Logic Levels		High (SMPS on)		2.4			V
ONLDO Iliput Logic Levels		Low (SMPS off)			<u> </u>	0.8	\ \

- Note 1: DC output accuracy specifications refer to the threshold of the error comparator. When the inductor is in continuous conduction, the MAX17101 regulates the valley of the output ripple, so the actual DC output voltage is higher than the trip level by 50% of the output ripple voltage. In discontinuous conduction (IOUT < ILOAD(SKIP)), the output voltage has a DC regulation level higher than the error-comparator threshold by approximately 1.5% due to slope compensation.
- Note 2: On-time and off-time specifications are measured from 50% point to 50% point at the DH pin with LX = PGND, VBST = 5V, and a 500pF capacitor from DH to LX to simulate external MOSFET gate capacitance. Actual in-circuit times might be different due to MOSFET switching speeds.
- **Note 3:** Specifications to $T_A = -40^{\circ}C$ are guaranteed by design and not production tested.
- Note 4: Specifications increased by 1Ω to account for test measurement error.

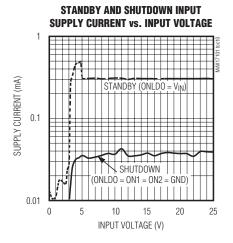
Typical Operating Characteristics

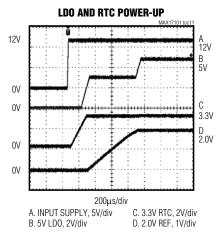
(Circuit of Figure 1, V_{IN} = 12V, V_{DD} = V_{CC} = 5V, TON = REF, T_A = +25°C, unless otherwise noted.)

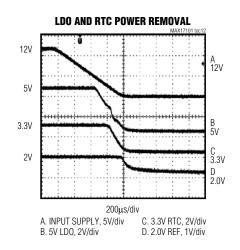


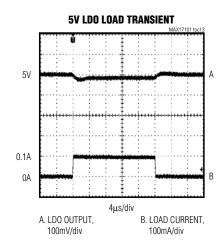
Typical Operating Characteristics (continued)

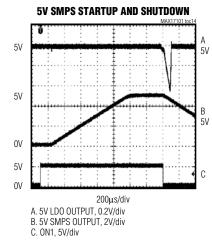
(Circuit of Figure 1, V_{IN} = 12V, V_{DD} = V_{CC} = 5V, TON = REF, T_A = +25°C, unless otherwise noted.)

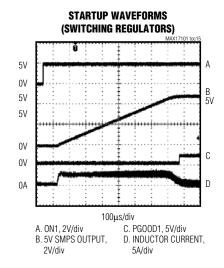






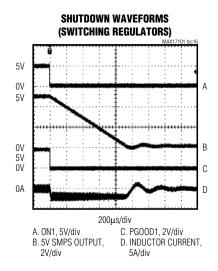


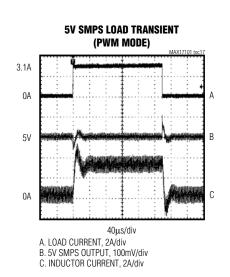


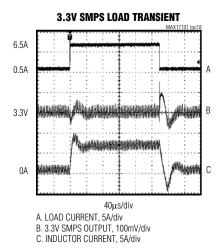


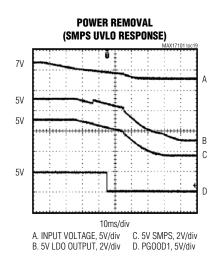
Typical Operating Characteristics (continued)

(Circuit of Figure 1, V_{IN} = 12V, V_{DD} = V_{CC} = 5V, TON = REF, T_A = +25°C, unless otherwise noted.)









Pin Description

PIN	NAME	FUNCTION
1	REF	2V Reference-Voltage Output. Bypass REF to AGND with a 0.1μF or greater ceramic capacitor. The reference can source up to 50μA for external loads. Loading REF degrades output-voltage accuracy according to the REF load-regulation error (see the <i>Typical Operating Characteristics</i>). The reference shuts down when ON1, ON2, and ONLDO are all pulled low.
2	TON	Switching-Frequency Setting Input. Select the OUT1/OUT2 switching frequencies by connecting TON as follows for: High (V _{CC}) = 200kHz/300kHz Open (REF) = 400kHz/300kHz GND = 400kHz/500kHz
3	Vcc	Analog Supply Voltage Input. Connect V_{CC} to the system supply voltage with a series 50Ω resistor, and bypass to analog ground using a $1\mu F$ or greater ceramic capacitor.
4	ONLDO	Enable Input for LDO. Drive ONLDO high to enable the linear regulator (LDO) output. Drive ONLDO low to shut down the linear regulator output.
5	RTC	3.3V Always-On Linear Regulator Output for RTC Power. Bypass RTC with a 1µF or greater ceramic capacitor to analog ground. RTC can source at least 5mA for external load support. RTC power-up is required for controller operation.
6	IN	Power-Input Supply. IN powers the linear regulators (RTC and LDO) and senses the input voltage for the Quick-PWM on-time one-shot timers. The high-side MOSFET's on-time is inversely proportional to the input voltage. Bypass IN with a 0.1µF or greater ceramic capacitor to PGND close to the MAX17101.
7	LDO	Tracking Linear Regulator Output. Bypass LDO with a 4.7µF or greater ceramic capacitor. LDO can source at least 100mA for external load support. LDO is powered from IN and its regulation threshold is set by LDOSEL. For preset 5V operation, connect LDOSEL directly to GND. For preset 3.3V operation, connect LDOSEL directly to VCC. When LDO is used for 5V operation, LDO must supply VCC and VDD.
8	LDOSEL	Input for the Linear Regulator Output Voltage Selection. LDOSEL sets the LDO regulation voltage. Connect LDOSEL to GND for a fixed 5V linear-regulator output voltage, or connect LDOSEL to V _{CC} for a fixed 3.3V linear-regulator output voltage.
9	BYP	Linear Regulator Bypass Input. When BYP voltage exceeds 93.5% of the LDO voltage, the controller bypasses the LDO output to the BYP input. The bypass switch is disabled if the LDO voltage drops by 8.5% from its nominal regulation threshold. When not being used, connect BYP to GND.
10	OUT1	Output Voltage-Sense Input for SMPS1. OUT1 is an input to the Quick-PWM on-time one-shot timer. OUT1 also serves as the feedback input for the preset 5V (FB1 = GND) and 1.5V (FB1 = V _{CC}) output voltage settings.
11	FB1	Adjustable Feedback Voltage-Sense Connection for SMPS1. Connect FB1 to GND for fixed 5V operation. Connect FB1 to V _{CC} for fixed 1.5V operation. Connect FB1 to an external resistive voltage-divider from OUT1 to analog ground to adjust the output voltage between 0.7V and 5.5V.
12	ILIM1	Valley Current-Limit Adjustment for SMPS1. The GND - LX1 current-limit threshold is 1/10 the voltage present on ILIM1 over a 0.2V to 2V range. An internal 5µA current source allows this voltage to be set with a single resistor between ILIM1 and analog ground.
13	PGOOD1	Open-Drain Power-Good Output for SMPS1. PGOOD1 is low when the output voltage is more than 16% (typ) below the nominal regulation threshold, during soft-start, in shutdown, and after the fault latch has been tripped. After the soft-start circuit has terminated, PGOOD1 becomes high impedance if the output is in regulation.

Pin Description (continued)

PIN	NAME	FUNCTION
14	ON1	Enable Input for SMPS1. Drive ON1 high to enable SMPS1. Drive ON1 low to shut down SMPS1.
15	DH1	High-Side Gate-Driver Output for SMPS1. DH1 swings from LX1 to BST1.
16	LX1	Inductor Connection for SMPS1. Connect LX1 to the switched side of the inductor. LX1 is the lower supply rail for the DH1 high-side gate driver.
17	BST1	Boost Flying-Capacitor Connection for SMPS1. Connect to an external capacitor as shown in Figure 1. An optional resistor in series with BST1 allows the DH1 turn-on current to be adjusted.
18	DL1	Low-Side Gate-Driver Output for SMPS1. DL1 swings from PGND to V _{DD} .
19	V _{DD}	Supply-Voltage Input for the DL_ Gate Drivers. Connect to a 5V supply. Also connect to the drain of the BST diode switch.
20	SECFB	Secondary Feedback Input. The secondary feedback input forces the SMPS1 output into ultrasonic mode when the SECFB voltage drops below its 2V threshold voltage. This forces DL1 and DH1 to switch, allowing the system to refresh an external low-power charge pump being driven by DL1 (see Figure 1 for the <i>Standard Application Circuit—Main Supply</i>). Connect SECFB to V _{CC} (the 5V bias supply) to disable secondary feedback.
21	AGND	Analog Ground. Connect backside exposed pad to AGND.
22	PGND	Power Ground
23	DL2	Low-Side Gate-Driver Output for SMPS2. DL2 swings from PGND to V _{DD} .
24	BST2	Boost Flying-Capacitor Connection for SMPS2. Connect to an external capacitor as shown in Figure 1. An optional resistor in series with BST2 allows the DH2 turn-on current to be adjusted.
25	LX2	Inductor Connection for SMPS2. Connect LX2 to the switched side of the inductor. LX2 is the lower supply rail for the DH2 high-side gate driver.
26	DH2	High-Side Gate-Driver Output for SMPS2. DH2 swings from LX2 to BST2.
27	ON2	Enable Input for SMPS2. Drive ON2 high to enable SMPS2. Drive ON2 low to shut down SMPS2.
28	PGOOD2	Open-Drain Power-Good Output for SMPS2. PGOOD2 is low when the output voltage is more than 150mV (typ) below the REFIN2 voltage or more than 16% below the preset voltage, during soft-start, in shutdown, and when the fault latch has been tripped. After the soft-start circuit has terminated, PGOOD2 becomes high impedance if the output is in regulation. PGOOD2 is blanked—forced high-impedance state—when a dynamic REFIN transition is detected.
29	SKIP	Pulse-Skipping Control Input. This three-level input determines the operating mode for the switching regulators: High (V _{CC} or 3.3V) = forced-PWM operation Open/REF (2V) = ultrasonic mode GND = pulse-skipping mode
30	OUT2	Output Voltage-Sense Input for SMPS2. OUT2 is an input to the Quick-PWM on-time one-shot timer. OUT2 also serves as the feedback input for the preset 3.3V (REFIN2 = V _{CC}) and 1.05V (REFIN2 = RTC).
31	ILIM2	Valley Current-Limit Adjustment for SMPS2. The GND - LX2 current-limit threshold is 1/10 the voltage present on ILIM2 over a 0.2V to 2V range. An internal 5µA current source allows this voltage to be set with a single resistor between ILIM2 and analog ground.
32	REFIN2	External Reference Input for SMPS2. REFIN2 sets the feedback-regulation voltage (V _{OUT2} = V _{REFIN2}). Connect REFIN2 to RTC for fixed 1.05V operation. Connect REFIN2 to V _{CC} for fixed 3.3V operation.
_	EP	Exposed Pad. Connect the backside exposed pad to AGND.

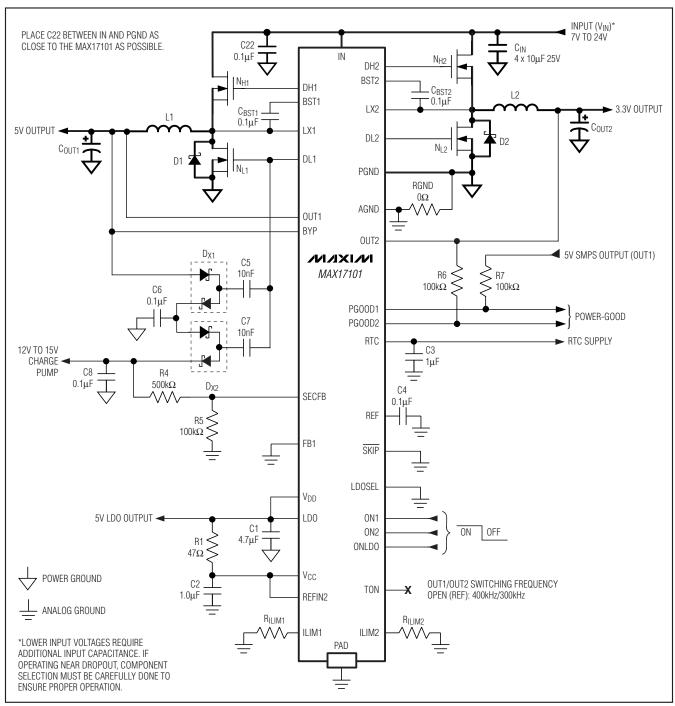


Figure 1. Standard Application Circuit—Main Supply

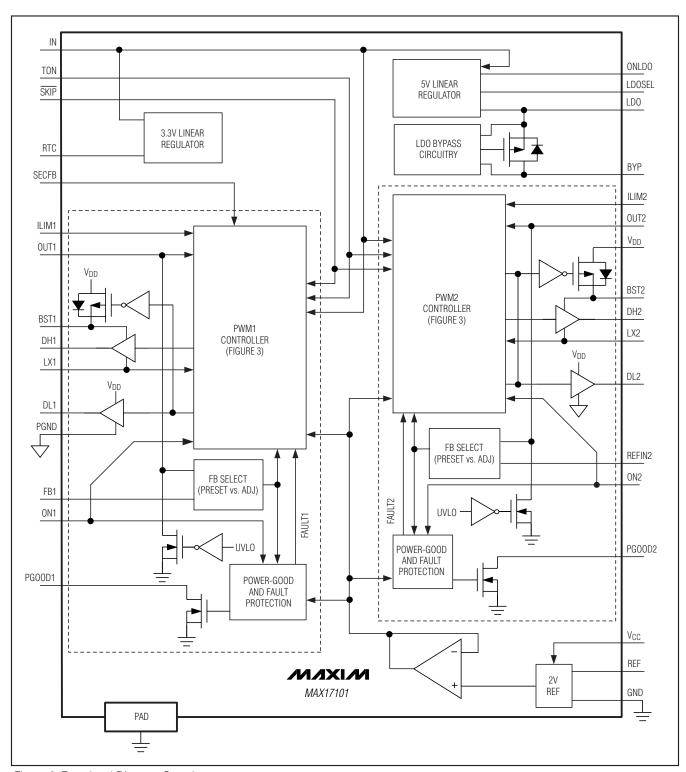


Figure 2. Functional Diagram Overview

Table 1. Component Selection for Standard Applications

COMPONENT	400kHz/300kHz SMPS 1: 5V AT 5A SMPS 2: 3.3V AT 8A	400kHz/500kHz SMPS 1: 5V AT 3A SMPS 2: 3.3V AT 5A	400kHz/300kHz SMPS 1: 1.5V AT 8A SMPS 2: 1.05V AT 5A
Input Voltage	V _{IN} = 7V to 24V	V _{IN} = 7V to 24V	V _{IN} = 7V to 24V
Input Capacitor (C _{IN})	(4x) 10µF, 25V Taiyo Yuden	(2x) 10µF, 25V Taiyo Yuden	(4x) 10μF, 25V Taiyo Yuden
SMPS 1		·	•
Output Capacitor (COUT1)	330μF, 6V, 18mΩ SANYO 6TPE330MIL	330μF, 6V, 18mΩ SANYO 6TPE330MIL	(2x) 330μF, 2V, 7mΩ SANYO 2TPF330M7
Inductor (L1)	4.3μH, 11.4mΩ, 11A Sumida CEP125U	4.7μH, 9.8mΩ, 7A Sumida CDRH10D68	1.5μH, 12A, 7mΩ NEC/TOKIN MPLC1040L1R5
High-Side MOSFET (N _{H1})	Fairchild Semiconductor FDS6612A 26mΩ/30mΩ, 30V	Vishay Siliconix Si4814DY Dual 30V MOSFET	Fairchild Semiconductor FDS8690 8.6m Ω /11.4m Ω , 30V
Low-Side MOSFET (N _{L1})	Fairchild Semiconductor FDS6670S $9m\Omega/11.5m\Omega$, 30V	High side: $19\text{m}\Omega/23\text{m}\Omega$ Low side: $18\text{m}\Omega/22\text{m}\Omega$	Fairchild Semiconductor FDMS8660S 2.6m Ω /3.5m Ω , 30V
Current-Limit Resistor (R _{ILIM1})	200kΩ	150kΩ	49.9kΩ
SMPS 2	·		•
Output Capacitor (Cout2)	470μF, 4V, 15mΩ SANYO 4TPE470MFL	330μF, 6V, 18mΩ SANYO 6TPE330MIL	330μF, 2V, 7mΩ SANYO 2TPF330M7
Inductor (L2)	4.3μH, 11.4mΩ, 11A Sumida CEP125U	4.7μH, 9.8mΩ, 7A Sumida CDRH10D68	1.5μH, 12A, 7mΩ NEC/TOKIN MPLC1040L1R5
High-Side MOSFET (N _{H2})	Fairchild Semiconductor FDS8690 8.6m Ω /11.4m Ω , 30V	Vishay Siliconix Si4814DY	Fairchild Semiconductor FDS8690 8.6m Ω /11.4m Ω , 30V
Low-Side MOSFET (NL2)	Fairchild Semiconductor FDMS8660S 2.6mΩ/3.5mΩ, 30V	Dual 30V MOSFET High side: 19mΩ/23mΩ Low side: 18mΩ/22mΩ	Fairchild Semiconductor FDMS8660S 2.6m Ω /3.5m Ω Ω , 30V
Current-Limit Resistor (R _{ILIM2})	200kΩ	200kΩ	49.9kΩ

Table 2. Component Suppliers

SUPPLIER	WEBSITE
AVX Corporation	www.avxcorp.com
Central Semiconductor	www.centralsemi.com
Fairchild Semiconductor	www.fairchildsemi.com
International Rectifier	www.irf.com
KEMET Corp.	www.kemet.com
NEC/TOKIN Corp.	www.nec-tokinamerica.com
Panasonic Corp.	www.panasonic.com
Philips/nxp	www.semiconductors.philips.com
Pulse Engineering	www.pulseeng.com

SUPPLIER	WEBSITE
Renesas Technology Corp.	www.renesas.com
SANYO Electric Co., Ltd.	www.sanyodevice.com
Sumida Corp.	www.sumida.com
Taiyo Yuden	www.t-yuden.com
TDK Corp.	www.component.tdk.com
TOKO America, Inc.	www.tokoam.com
Vishay (Dale, Siliconix)	www.vishay.com
Würth Elektronik GmbH & Co. KG	www.we-online.com

Detailed Description

The MAX17101 step-down controller is ideal for high-voltage, low-power supplies for notebook computers. Maxim's Quick-PWM pulse-width modulator in the MAX17101 is specifically designed for handling fast load steps while maintaining a relatively constant operating frequency and inductor operating point over a wide range of input voltages. The Quick-PWM architecture circumvents the poor load-transient timing problems of fixed-frequency current-mode PWMs, while also avoiding the problems caused by widely varying switching frequencies in conventional constant-on-time and constant-off-time PWM schemes. Figure 2 is a functional diagram—QuickPWM core.

The MAX17101 includes several features for multipurpose notebook functionality, allowing this controller to be used two or three times in a single notebook—main, I/O chipset, and graphics. The MAX17101 includes a 100mA LDO that can be configured for preset 5V operation—ideal for initial power-up of the notebook and main supply. Additionally, the MAX17101 includes a 3.3V, 5mA RTC supply that remains always enabled, which can be used to power the RTC supply and system pullups when the notebook shuts down. The MAX17101 also includes an optional secondary feedback input that allows an unregulated charge pump or secondary winding to be included on a supply-ideal for generating the low-power 12V-to-15V load switch supply. Finally, the MAX17101 includes a reference input on SMPS 2 that allows dynamic voltage transitions when driven by an adjustable resistive voltage-divider or DAC—ideal for the dynamic graphics core requirements.

3.3V RTC Power

The MAX17101 includes a low-current (5mA) linear regulator that remains active as long as the input supply (IN) exceeds 2V (typ). The main purpose of this "always-enabled" linear regulator is to power the real-time clock (RTC) when all other notebook regulators are disabled. RTC also serves as the main bias supply of the MAX17101 so it powers up before the LDC and switching regulators. The RTC regulator sources at least 5mA for external loads.

Adjustable 100mA Linear Regulator

The MAX17101 includes a high-current (100mA) linear regulator that may be configured for preset 5V or 3.3V operation. When the MAX17101 is configured as a main supply, this LDO is required to generate the 5V bias supply necessary to power up the switching regulators. Once the switching regulators are enabled, the LDO may be bypassed using the dedicated BYP input. The adjustable linear regulator allows generation of the 3.3V suspend supply or buffered low-power chipset and GPU reference supplies. The MAX17101 LDO sources at least 100mA of supply current.

Bypass Switch

The MAX17101 includes an independent LDO bypass input that allows the LDO to be bypassed by either switching regulator output or from a different regulator all together. When the bypass voltage (BYP) exceeds 93.5% of the LDO output voltage for 500µs, the MAX17101 reduces the LDO regulation threshold and turns on an internal p-channel MOSFET to short BYP to LDO. Instead of disabling the LDO when the MAX17101 enables the bypass switch, the controller reduces the LDO regulation voltage, which effectively places the linear regulator in a standby state while switched over, yet allows a fast recovery if the bypass supply drops.

Connect BYP to GND when not used to avoid unintentional conduction through the body diode (BYP to LDO) of the p-channel MOSFET.

5V Bias Supply (VCC/VDD)

The MAX17101 requires an external 5V bias supply (V_{DD} and V_{CC}) in addition to the battery. Typically, this 5V bias supply is generated by either the internal 100mA LDO (when configured for a main supply) or from the notebook's 95%-efficient 5V main supply (when configured for I/O chipset, DDR, or graphics). Keeping these bias supply inputs independent improves the overall efficiency and allows the internal linear regulator to be used for other applications as well.

The V_{DD} bias supply input powers the internal gate drivers and the V_{CC} bias supply input powers the analog control blocks. The maximum current required is dominated by the switching losses of the drivers and may be estimated as follows:

 $I_{BIAS(MAX)} = I_{CC(MAX)} + f_{SW}Q_G \approx 30mA \text{ to } 60mA \text{ (typ)}$

Free-Running Constant-On-Time PWM Controller with Input Feed-Forward

The Quick-PWM control architecture is a pseudo-fixed-frequency, constant on-time, current-mode regulator with voltage feed-forward. This architecture relies on the output filter capacitor's ESR to act as a current-sense resistor, so the feedback ripple voltage provides the PWM ramp signal. The control algorithm is simple: the high-side switch on-time is determined solely by a one-shot whose pulse width is inversely proportional to input voltage and directly proportional to output voltage. Another one-shot sets a minimum off-time (300ns typ). The on-time one-shot is triggered if the error comparator is low, the low-side switch current is below the valley current-limit threshold, and the minimum off-time one-shot has timed out.

On-Time One-Shot

The heart of the PWM core is the one-shot that sets the high-side switch on-time. This fast, low-jitter, adjustable one-shot includes circuitry that varies the on-time in response to battery and output voltage. The high-side switch on-time is inversely proportional to the battery voltage as sensed by the IN input, and proportional to the output voltage:

On-Time = K (VOUT/VIN)

where K (switching period) is set by the trilevel TON input (see the *Pin Description* section). High-frequency (400kHz/500kHz) operation optimizes the application for the smallest component size, trading off efficiency due to higher switching losses. This might be acceptable in ultra-portable devices where the load currents are lower and the controller is powered from a lower voltage supply. Low-frequency (200kHz/300kHz) operation offers the best overall efficiency at the expense of component size and board space.

For continuous conduction operation, the actual switching frequency can be estimated by:

$$f_{SW} = \frac{V_{OUT} + V_{DROP1}}{t_{ON}(V_{IN} + V_{DROP2})}$$

where V_{DROP1} is the sum of the parasitic voltage drops in the inductor discharge path, including synchronous rectifier, inductor, and PCB resistances; V_{DROP2} is the sum of the resistances in the charging path, including the high-side switch, inductor, and PCB resistances; and t_{ON} is the on-time calculated by the MAX17101.

Table 3. Approximate K-Factor Errors

SWITCHING REGULATOR	TON SETTING (kHz)	TYPICAL K-FACTOR (μs)	K-FACTOR ERROR (%)	COMMENTS
SMPS 1	200 TON = V _{CC}	5.0	±10	Use for absolute best efficiency.
	400 TON = REF or GND	2.5	±12.5	Useful in 3-cell systems for lighter loads than the CPU core or where size is key.
SMPS 2	300 TON = REF or V _{CC}	3.3	±10	Considered mainstream by current standards.
	500 TON = GND	2.0	±12.5	Good operating point for compound buck designs or desktop circuits.

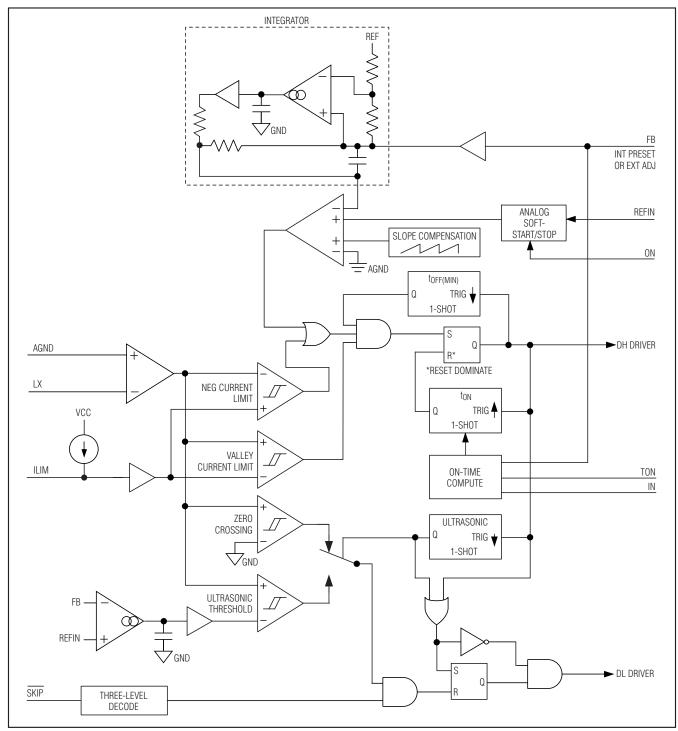


Figure 3. Functional Diagram—Quick-PWM Core

Modes of Operation

Forced-PWM Mode (SKIP = Vcc)

The low-noise forced-PWM mode (SKIP = V_{CC}) disables the zero-crossing comparator, which controls the low-side switch on-time. This forces the low-side gatedrive waveform to constantly be the complement of the high-side gate-drive waveform, so the inductor current reverses at light loads while DH maintains a duty factor of V_{OUT}/V_{IN}. The benefit of forced-PWM mode is to keep the switching frequency fairly constant. However, forced-PWM operation comes at a cost: the no-load 5V bias current remains between 20mA to 60mA depending on the switching frequency and MOSFET selection.

The MAX17101 automatically uses forced-PWM operation during all transitions—startup and shutdown—regardless of the SKIP configuration.

Automatic Pulse-Skipping Mode (SKIP = GND)

In skip mode (SKIP = GND), an inherent automatic switchover to PFM takes place at light loads. This switchover is affected by a comparator that truncates the low-side switch on-time at the inductor current's zero crossing. The zero-crossing comparator threshold is set by the differential across LX and AGND.

DC output-accuracy specifications refer to the integrated threshold of the error comparator. When the inductor is in continuous conduction, the MAX17101 regulates the valley of the output ripple and the internal integrator removes the actual DC output-voltage error caused by the output-ripple voltage and internal slope compensation. In discontinuous conduction ($\overline{\text{SKIP}} = \text{GND}$ and $\overline{\text{IOUT}} < \overline{\text{ILOAD(SKIP)}}$), the integrator cannot correct for the low-frequency output ripple error, so the output voltage has a DC regulation level higher than the error comparator threshold by approximately 1.5% due to slope compensation and output ripple voltage.

Ultrasonic Mode (SKIP = Open or REF)

Leaving SKIP unconnected or connecting SKIP to REF (2V) activates a unique pulse-skipping mode with a guaranteed minimum switching frequency of 20kHz. This ultrasonic pulse-skipping mode eliminates audiofrequency modulation that would otherwise be present when a lightly loaded controller automatically skips pulses. In ultrasonic mode, the controller automatically transitions to fixed-frequency PWM operation when the load reaches the same critical conduction point (ILOAD(SKIP)) that occurs when normally pulse skipping.

An ultrasonic pulse occurs (Figure 4) when the controller detects that no switching has occurred within the last 37µs or when SECFB drops below its feedback threshold. Once triggered, the ultrasonic circuitry pulls

DL high, turning on the low-side MOSFET to induce a negative inductor current. After the inductor current reaches the negative ultrasonic current threshold, the controller turns off the low-side MOFET (DL pulled low) and triggers a constant on-time (DH driven high). When the on-time has expired, the controller reenables the low-side MOSFET until the inductor current drops below the zero-crossing threshold. Starting with a DL pulse greatly reduces the peak output voltage when compared to starting with a DH pulse.

The output voltage at the beginning of the ultrasonic pulse determines the negative ultrasonic current threshold, resulting in the following equation:

VNEG(US) = ILRCS = (VNOM - VFB) x 0.385V

where V_{NOM} is the nominal feedback-regulation voltage, and V_{FB} is the actual feedback voltage ($V_{FB} > V_{NOM}$), and R_{CS} is the current-sense resistance seen across LX to AGND.

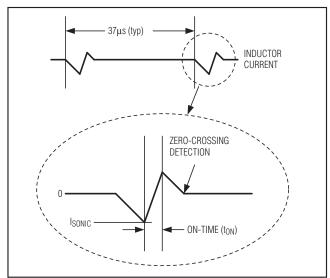


Figure 4. Ultrasonic Waveforms

Secondary Feedback: SECFB—OUT1 ONLY

When the controller skips pulses (\$\overline{SKIP}\$ = GND or REF), the long time between pulses (especially if the output is sinking current) allows the external charge-pump voltage or transformer secondary winding voltage to drop. When the SECFB voltage drops below its 2V feedback threshold, the MAX17101 issues an ultrasonic pulse (regardless of the ultrasonic one-shot state). This forces a switching cycle, allowing the external unregulated charge pump (or transformer secondary winding) to be refreshed. See the Ultrasonic Mode (\$\overline{SKIP}\$ = Open or REF) section for switching cycle sequence/specifications.

Automatic Fault Blanking

When the MAX17101 automatically detects that the internal target and REFIN2 are more than ±25mV (typ) apart, the controller automatically blanks PGOOD2, blanks the UVP protection, and sets the OVP threshold to REF + 200mV. The blanking remains until 1) the internal target and REFIN2 are within ±20mV of each other and 2) an edge is detected on the error amplifier signifying that the output is in regulation. This prevents the system or internal fault protection from shutting down the controller during transitions.

Valley Current-Limit Protection

The current-limit circuit employs a unique "valley" current-sensing algorithm that senses the inductor current through the low-side MOSFET—across LX to AGND. If the current through the low-side MOSFET exceeds the valley current-limit threshold, the PWM controller is not allowed to initiate a new cycle. The actual peak current is greater than the valley current-limit threshold by an amount equal to the inductor ripple current. Therefore, the exact current-limit characteristic and maximum load capability are a function of the inductor value and battery voltage. When combined with the undervoltage protection circuit, this current-limit method is effective in almost every circumstance.

In forced-PWM mode, the MAX17101 also implements a negative current limit to prevent excessive reverse inductor currents when V_{OUT} is sinking current. The negative current-limit threshold is set to approximately 120% of the positive current limit.

POR. UVLO

When V_{CC} rises above the power-on reset (POR) threshold, the MAX17101 clears the fault latches, forces the low-side MOSFET to turn on (DL high), and resets the soft-start circuit, preparing the controller for power-up. However, the V_{CC} undervoltage lockout (UVLO) circuitry inhibits switching until V_{CC} reaches 4.2V (typ). When V_{CC} rises above 4.2V and the controller has been enabled (ON_ pulled high), the controller activates the enabled PWM controllers and initializes soft-start.

When VCC drops below the UVLO threshold (falling edge), the controller stops switching, and DH and DL are pulled low and a 10Ω switch discharges the outputs. When the 2V POR falling-edge threshold is reached, the DL state no longer matters since there is not enough voltage to force the switching MOSFETs into a low on-resistance state, so the controller pulls DL high, allowing a soft discharge of the output capacitors (damped response). However, if the VCC recovers before reaching the falling POR threshold, DL remains low until the error comparator has been properly powered up and triggers an on-time.

Only one enable input needs to be toggled to clear the fault latches and activate both outputs.

Soft-Start and Soft-Shutdown

The MAX17101 includes voltage soft-start and soft-shutdown—slowly ramping up and down the target voltage. During startup, the slew-rate control softly slews the preset/fixed target voltage over a 1ms startup period or its tracking voltage (REFIN2 < 2V) with a 1mV/µs slew rate. This long startup period reduces the inrush current during startup.

When ON1 or ON2 is pulled low or the output undervoltage fault latch is set, the respective output automatically enters soft-shutdown—the regulator enters PWM mode and ramps down its preset/fixed output voltage over a 1ms period or its tracking voltage (REFIN2 < 2V) with a 1mV/µs slew rate. After the output voltage drops below 0.1V, the MAX17101 pulls DL high, clamping the output and LX switching node to ground, preventing leakage currents from pulling up the output and minimizing the negative output-voltage undershoot during shutdown.

Output Voltage

DC output-accuracy specifications in the *Electrical Characteristics* table refer to the error comparator's threshold. When the inductor continuously conducts, the MAX17101 regulates the valley of the output ripple, so the actual DC output voltage is lower than the slope-compensated trip level by 50% of the output ripple voltage. For PWM operation (continuous conduction), the output voltage is accurately defined by the following equation:

$$V_{OUT(PWM)} = V_{NOM} + \left(\frac{V_{RIPPLE}}{2A_{CCV}}\right)$$

where V_{NOM} is the nominal feedback voltage, A_{CCV} is the integrator's gain, and V_{RIPPLE} is the output ripple voltage ($V_{RIPPLE} = ESR \times \Delta I_{INDUCTOR}$, as described in the *Output Capacitor Selection* section).

In discontinuous conduction (IOUT < ILOAD(SKIP)), the longer off-times allow the slope compensation to increase the threshold voltage by as much as 1%, so the output voltage regulates slightly higher than it would in PWM operation.

Internal Integrator

The internal integrator improves the output accuracy by removing any output accuracy errors caused by the slope compensation, output ripple voltage, and erroramplifier offset. Therefore, the DC accuracy (in forced-PWM mode) depends on the integrator's gain, the integrator's offset, and the accuracy of the integrator's reference input.

Adjustable/Fixed Output Voltages

Connect FB1 to GND for fixed 5V operation. Connect FB1 to V_{CC} for fixed 1.5V operation. Connect FB1 to an external resistive voltage-divider from OUT1 to analog ground to adjust the output voltage between 0.7V and 5.5V. During soft-shutdown, application circuits configured for adjustable feedback briefly switch modes when FB1 drops below the 110mV dual-mode threshold.

Choose RFBL (resistance from FB1 to AGND) to be approximately 49.9k Ω and solve for RFBH (resistance from OUT1 to FB1) using the following equation:

$$RFBH = RFBL \left(\frac{VOUT1}{0.7V} - 1 \right)$$

Connect REFIN2 to VCC for fixed 3.3V operation. Connect REFIN2 to RTC (3.3V) for fixed 1.05V operation. Connect REFIN2 to an external resistive voltage-divider from REF to analog ground to adjust the output voltage between 0.8V and 2V.

Choose RREFINL (resistance from REFIN2 to GND) to be approximately 49.9k Ω and solve for RREFINH (resistance from REF to REFIN2) using the equation:

$$R_{REFINH} = R_{REFINL} \left(\frac{V_{REF}}{V_{OUT2}} - 1 \right)$$

Power-Good Outputs (PGOOD) and Fault Protection

PGOOD is the open-drain output that continuously monitors the output voltage for undervoltage and overvoltage conditions. PGOOD_ is actively held low in shutdown (ON_ = GND), during soft-start or soft-shutdown. Approximately 20µs (typ) after the soft-start terminates, PGOOD_ becomes high impedance as long as the feedback voltage exceeds 85% of the nominal

fixed-regulation voltage or within 150mV of the REFIN2 input voltage. PGOOD_ goes low if the feedback voltage drops 16% below the fixed target voltage, or if the output voltage drops 150mV below the dynamic REFIN2 voltage, or if the SMPS controller is shut down. For a logic-level PGOOD_ output voltage, connect an external pullup resistor between PGOOD_ and VDD. A 100k Ω pullup resistor works well in most applications.

Overvoltage Protection (OVP)

When the output voltage rises 16% above the regulation voltage, the controller immediately pulls the respective PGOOD_ low, sets the overvoltage fault latch, and immediately pulls the respective DL_ high—clamping the output to GND. Toggle either ON1 or ON2 input, or cycle VCC power below its POR threshold to clear the fault latch and restart the controller.

Undervoltage Protection (UVP)

When the output voltage drops 30% below the regulation voltage, the controller immediately pulls the respective PGOOD_ low, sets the undervoltage fault latch, and begins the shutdown sequence. After the output voltage drops below 0.1V, the synchronous rectifier turns on, clamping the output to GND. Toggle either ON1 or ON2 input, or cycle V_{CC} power below its POR threshold to clear the fault latch and restart the controller.

Thermal-Fault Protection (T_{SHDN})

The MAX17101 features a thermal-fault protection circuit. When the junction temperature rises above +160°C, a thermal sensor activates the fault latch, pulls PGOOD1 and PGOOD2 low, enables the 10 Ω discharge circuit, and disables the controller—DH and DL pulled low. Toggle ONLDO or cycle IN power to reactivate the controller after the junction temperature cools by 15°C.

Table 4. Fault Protection and Shutdown Operation Table

MODE	CONTROLLER STATE	DRIVER STATE
Shutdown (ON_ = High to Low); Output UVP (Latched)	Voltage soft-shutdown initiated. Internal error-amplifier target slowly ramped down to GND and output actively discharged (automatically enters forced-PWM mode).	DL driven high and DH pulled low after soft-shutdown completed (output < 0.1V).
Output OVP (Latched)	Controller shuts down and EA target internally slewed down. Controller remains off until ON_ toggled or VCC power cycled.	DL immediately driven high, DH pulled low.
V _{CC} UVLO Falling-Edge Thermal Fault (Latched)	SMPS controller disabled (assuming ON_ pulled high), 10Ω output discharge active.	DL and DH pulled low.
V _{CC} UVLO Rising Edge	SMPS controller enabled (assuming ON_ pulled high).	DL driven high, DH pulled low.
V _{CC} POR	SMPS inactive, 10Ω output discharge active.	DL driven high, DH pulled low.

Design Procedure

Firmly establish the input-voltage range and maximum load current before choosing a switching frequency and inductor operating point (ripple-current ratio). The primary design trade-off lies in choosing a good switching frequency and inductor operating point, and the following four factors dictate the rest of the design:

- Input Voltage Range: The maximum value (VIN(MAX)) must accommodate the worst-case, high AC-adapter voltage. The minimum value (VIN(MIN)) must account for the lowest battery voltage after drops due to connectors, fuses, and battery-selector switches. If there is a choice at all, lower input voltages result in better efficiency.
- Maximum Load Current: There are two values to consider. The peak load current (ILOAD(MAX)) determines the instantaneous component stresses and filtering requirements and thus drives output capacitor selection, inductor saturation rating, and the design of the current-limit circuit. The continuous load current (ILOAD) determines the thermal stresses and thus drives the selection of input capacitors, MOSFETs, and other critical heatcontributing components.
- Switching Frequency: This choice determines the basic trade-off between size and efficiency. The optimal frequency is largely a function of maximum input voltage due to MOSFET switching losses that are proportional to frequency and V_{IN}². The optimum frequency is also a moving target due to rapid improvements in MOSFET technology that are making higher frequencies more practical.
- Inductor Operating Point: This choice provides trade-offs between size vs. efficiency and transient response vs. output ripple. Low inductor values provide better transient response and smaller physical size, but also result in lower efficiency and higher output ripple due to increased ripple currents. The minimum practical inductor value is one that causes the circuit to operate at the edge of critical conduction (where the inductor current just touches zero with every cycle at maximum load). Inductor values lower than this grant no further sizereduction benefit. The optimum operating point is usually found between 20% and 50% ripple current. When pulse skipping (SKIP low and light loads), the inductor value also determines the load-current value at which PFM/PWM switchover occurs.

Inductor Selection

The switching frequency and inductor operating point determine the inductor value as follows:

$$L = \frac{V_{RIPPLE}(V_{IN} - V_{OUT})}{V_{IN}f_{SW}I_{LOAD(MAX)LIR}}$$

For example: $I_{LOAD(MAX)} = 4A$, $V_{IN} = 12V$, $V_{OUT2} = 2.5V$, $f_{SW} = 355kHz$, 30% ripple current or LIR = 0.3:

$$L = \frac{2.5V \times (12V - 2.5V)}{12V \times 355kHz \times 4A \times 0.3} = 4.65\mu H$$

Find a low-loss inductor having the lowest possible DC resistance that fits in the allotted dimensions. Ferrite cores are often the best choice, although powdered iron is inexpensive and can work well at 200kHz. The core must be large enough not to saturate at the peak inductor current (IPEAK):

$$I_{PEAK} = I_{LOAD(MAX)} \left(1 + \frac{LIR}{2} \right)$$

Most inductor manufacturers provide inductors in standard values, such as 1.0µH, 1.5µH, 2.2µH, 3.3µH, etc. Also look for nonstandard values, which can provide a better compromise in LIR across the input voltage range. If using a swinging inductor (where the no-load inductance decreases linearly with increasing current), evaluate the LIR with properly scaled inductance values.

Transient Response

The inductor ripple current also impacts transient-response performance, especially at low V_{IN} - V_{OUT} differentials. Low inductor values allow the inductor current to slew faster, replenishing charge removed from the output filter capacitors by a sudden load step. The amount of output sag is also a function of the maximum duty factor, which can be calculated from the ontime and minimum off-time:

$$V_{SAG} = \frac{L\Big(\Delta I_{LOAD(MAX)}\Big)^2 \Bigg[\bigg(\frac{V_{OUT}K}{V_{IN}}\bigg) + t_{OFF(MIN)} \Bigg]}{2C_{OUT}V_{OUT} \Bigg[\bigg(\frac{\big(V_{IN} - V_{OUT}\big)K}{V_{IN}}\bigg) - t_{OFF(MIN)} \Bigg]}$$

where toff(MIN) is the minimum off-time (see the *Electrical Characteristics*) and K is from Table 3.

The amount of overshoot during a full-load to no-load transient due to stored inductor energy can be calculated as:

$$V_{SOAR} \approx \frac{\left(\Delta I_{LOAD(MAX)}\right)^2 L}{2C_{OUT}V_{OUT}}$$

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Setting the Current Limit

The minimum current-limit threshold must be great enough to support the maximum load current when the current limit is at the minimum tolerance value. The valley of the inductor current occurs at ILOAD(MAX) minus half the ripple current; therefore:

$$I_{LIM(VAL)} > I_{LOAD(MAX)} - \left(\frac{I_{LOAD(MAX)}LIR}{2}\right)$$

where $I_{LIM(VAL)}$ equals the minimum valley current-limit threshold voltage divided by the current-sense resistance (RSENSE). When using a $100k\Omega$ ILIM resistor, the minimum valley current-limit threshold is 40mV.

Connect a resistor between ILIM_ and analog ground (AGND) to set the adjustable current-limit threshold. The valley current-limit threshold is approximately 1/10 the ILIM voltage formed by the external resistance and internal 5µA current source. The 40k Ω to 400k Ω adjustment range corresponds to a 20mV to 200mV valley current-limit threshold. When adjusting the current limit, use 1% tolerance resistors to prevent significant inaccuracy in the valley current-limit tolerance.

Output Capacitor Selection

The output filter capacitor must have low enough equivalent series resistance (ESR) to meet output ripple and load-transient requirements, yet have high enough ESR to satisfy stability requirements.

For processor core voltage converters and other applications where the output is subject to violent load transients, the output capacitor's size depends on how much ESR is needed to prevent the output from dipping too low under a load transient. Ignoring the sag due to finite capacitance:

$$R_{ESR} \le \frac{V_{STEP}}{\Delta I_{LOAD(MAX)}}$$

In applications without large and fast load transients, the output capacitor's size often depends on how much ESR is needed to maintain an acceptable level of output voltage ripple. The output ripple voltage of a stepdown controller equals the total inductor ripple current multiplied by the output capacitor's ESR. Therefore, the maximum ESR required to meet ripple specifications is:

$$R_{ESR} \le \frac{V_{RIPPLE}}{I_{LOAD(MAX)LIR}}$$

The actual capacitance value required relates to the physical size needed to achieve low ESR, as well as to the chemistry of the capacitor technology. Thus, the capacitor is usually selected by ESR and voltage rating rather than by capacitance value (this is true of tantalums, OS-CONs, polymers, and other electrolytics).

When using low-capacity filter capacitors, such as ceramic capacitors, size is usually determined by the capacity needed to prevent VSAG and VSOAR from causing problems during load transients. Generally, once enough capacitance is added to meet the overshoot requirement, undershoot at the rising load edge is no longer a problem (see the VSAG and VSOAR equations in the *Transient Response* section). However, low-capacity filter capacitors typically have high ESR zeros that may affect the overall stability (see the *Output Capacitor Stability Considerations* section).

Output Capacitor Stability ConsiderationsFor Quick-PWM controllers, stability is determined by the value of the ESR zero relative to the switching fre-

the value of the ESR zero relative to the switching frequency. The boundary of instability is given by the following equation:

$$f_{ESR} \le \frac{f_{SW}}{\pi}$$

where:

$$f_{ESR} = \frac{1}{2\pi R_{ESR} C_{OUT}}$$

For a typical 300kHz application, the ESR zero frequency must be well below 95kHz, preferably below 50kHz. Tantalum and OS-CON capacitors in widespread use at the time of publication have typical ESR zero frequencies of 25kHz. In the design example used for inductor selection, the ESR needed to support 25mVp-pripple is 25mV/1.2A = 20.8m Ω . One 220µF/4V SANYO polymer (TPE) capacitor provides 15m Ω (max) ESR. This results in a zero at 48kHz, well within the bounds of stability.

Do not put high-value ceramic capacitors directly across the feedback sense point without taking precautions to ensure stability. Large ceramic capacitors can have a high-ESR zero frequency and cause erratic, unstable operation. However, it is easy to add enough series resistance by placing the capacitors a couple of inches downstream from the feedback sense point, which should be as close as possible to the inductor.

Unstable operation manifests itself in two related but distinctly different ways: double-pulsing and fast-feed-back loop instability. Double-pulsing occurs due to noise on the output or because the ESR is so low that there is not enough voltage ramp in the output voltage signal. This "fools" the error comparator into triggering a new cycle immediately after the 400ns minimum off-time period has expired. Double-pulsing is more annoying than harmful, resulting in nothing worse than increased output ripple. However, it can indicate the possible presence of loop instability due to insufficient ESR. Loop instability results in oscillations at the output after line or load steps. Such perturbations are usually damped, but can cause the output voltage to rise above or fall below the tolerance limits.

The easiest method for checking stability is to apply a very fast zero-to-max load transient and carefully observe the output voltage ripple envelope for overshoot and ringing. It can help to simultaneously monitor the inductor current with an AC current probe. Do not allow more than one cycle of ringing after the initial step-response under/overshoot.

Input Capacitor Selection

The input capacitor must meet the ripple current requirement (I_{RMS}) imposed by the switching currents:

$$I_{RMS} = I_{LOAD} \left(\frac{\sqrt{V_{OUT}(V_{IN} - V_{OUT})}}{V_{IN}} \right)$$

For most applications, nontantalum chemistries (ceramic, aluminum, or OS-CON) are preferred due to their resistance to power-up surge currents typical of systems with a mechanical switch or connector in series with the input. If the MAX17101 is operated as the second stage of a two-stage power conversion system, tantalum input capacitors are acceptable. In either configuration, choose a capacitor that has less than 10°C temperature rise at the RMS input current for optimal reliability and lifetime.

Power-MOSFET Selection

Most of the following MOSFET guidelines focus on the challenge of obtaining high load-current capability when using high-voltage (> 20V) AC adapters. Low-current applications usually require less attention.

The high-side MOSFET (N_H) must be able to dissipate the resistive losses plus the switching losses at both VIN(MIN) and VIN(MAX). Ideally, the losses at VIN(MIN) should be roughly equal to the losses at VIN(MAX), with lower losses in between. If the losses at VIN(MIN) are significantly higher, consider increasing the size of N_H.

Conversely, if the losses at $V_{IN(MAX)}$ are significantly higher, consider reducing the size of N_H . If V_{IN} does not vary over a wide range, maximum efficiency is achieved by selecting a high-side MOSFET (N_H) that has conduction losses equal to the switching losses.

Choose a low-side MOSFET (NL) that has the lowest possible on-resistance (RDS(ON)), comes in a moderate-sized package (i.e., 8-pin SO, DPAK, or D²PAK), and is reasonably priced. Ensure that the MAX17101 DL_ gate driver can supply sufficient current to support the gate charge and the current injected into the parasitic drain-to-gate capacitor caused by the high-side MOSFET turning on; otherwise, cross-conduction problems can occur. Switching losses are not an issue for the low-side MOSFET since it is a zero-voltage switched device when used in the step-down topology.

Power-MOSFET Dissipation

Worst-case conduction losses occur at the duty factor extremes. For the high-side MOSFET (N_H), the worst-case power dissipation due to resistance occurs at minimum input voltage:

$$PD(N_{H} \text{ Re sistive}) = \left(\frac{V_{OUT}}{V_{IN}}\right) (I_{LOAD})^{2} R_{DS(ON)}$$

Generally, use a small high-side MOSFET to reduce switching losses at high input voltages. However, the RDS(ON) required to stay within package power-dissipation often limits how small the MOSFET can be. The optimum occurs when the switching losses equal the conduction (RDS(ON)) losses. High-side switching losses do not become an issue until the input is greater than approximately 15V.

Calculating the power dissipation in high-side MOSFETs (N_H) due to switching losses is difficult, since it must allow for difficult-to-quantify factors that influence the turn-on and turn-off times. These factors include the internal gate resistance, gate charge, threshold voltage, source inductance, and PCB layout characteristics. The following switching loss calculation provides only a very rough estimate and is no substitute for breadboard evaluation, preferably including verification using a thermocouple mounted on $N_{\rm H}$:

$$\begin{split} \text{PD(N}_{H} \text{ Switching)} = & \left(\frac{\text{V}_{(MAX)}\text{ILOADfswQG(SW)}}{\text{IGATE}} \right) + \\ & \left(\frac{\text{V}_{IN}^{2}\text{Cossfsw}}{2} \right) \end{split}$$

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where COSS is the high-side MOSFET's output capacitance, $Q_{G(SW)}$ is the charge needed to turn on the high-side MOSFET, and I_{GATE} is the peak gate-drive source/sink current (1A typ).

Switching losses in the high-side MOSFET can become a heat problem when maximum AC adapter voltages are applied due to the squared term in the switching-loss equation provided above. If the high-side MOSFET chosen for adequate RDS(ON) at low battery voltages becomes extraordinarily hot when subjected to VIN(MAX), consider choosing another MOSFET with lower parasitic capacitance.

For the low-side MOSFET (N_L), the worst-case power dissipation always occurs at maximum battery voltage:

PD(N_L Resistive) =
$$\left[1 - \left(\frac{V_{OUT}}{V_{IN(MAX)}}\right)\right] (I_{LOAD})^2 R_{DS(ON)}$$

The absolute worst case for MOSFET power dissipation occurs under heavy overload conditions that are greater than I_{LOAD(MAX)}, but are not high enough to exceed the current limit and cause the fault latch to trip. To protect against this possibility, "overdesign" the circuit to tolerate:

$$I_{LOAD} \approx I_{VALLEY(MAX)} + \left(\frac{I_{LOAD(MAX)LIR}}{2}\right)$$

where IVALLEY(MAX) is the maximum valley current allowed by the current-limit circuit, including threshold tolerance and sense-resistance variation. The MOSFETs must have a relatively large heatsink to handle the overload power dissipation.

Choose a Schottky diode (D_L) with a forward voltage drop low enough to prevent the low-side MOSFET's body diode from turning on during the dead time. As a general rule, select a diode with a DC current rating equal to 1/3 the load current. This diode is optional and can be removed if efficiency is not critical.

Applications Information

Step-Down Converter Dropout Performance

The output-voltage adjustable range for continuous-conduction operation is restricted by the nonadjustable minimum off-time one-shot. For best dropout performance, use the slower (200kHz) on-time setting. When working with low input voltages, the duty-factor limit must be calculated using worst-case values for on- and off-times. Manufacturing tolerances and internal propagation delays introduce an error to the TON K-factor.

This error is greater at higher frequencies (Table 3). Also, keep in mind that transient response performance of buck regulators operated too close to dropout is poor, and bulk output capacitance must often be added (see the VSAG equation in the *Transient Response* section).

The absolute point of dropout is when the inductor current ramps down during the minimum off-time (Δl_{DOWN}) as much as it ramps up during the on-time (Δl_{UP}). The ratio h = $\Delta l_{UP}/\Delta l_{DOWN}$ indicates the controller's ability to slew the inductor current higher in response to increased load, and must always be greater than 1. As h approaches 1, the absolute minimum dropout point, the inductor current cannot increase as much during each switching cycle, and VSAG greatly increases unless additional output capacitance is used.

A reasonable minimum value for h is 1.5, but adjusting this up or down allows trade-offs between VSAG, output capacitance, and minimum operating voltage. For a given value of h, the minimum operating voltage can be calculated as:

$$V_{IN(MIN)} = \frac{V_{OUT} + V_{CHG}}{1 - \left(\frac{h \times t_{OFF(MIN)}}{K}\right)}$$

where V_{CHG} is the parasitic voltage drop in the charge path (see the *On-Time One-Shot* section), $t_{OFF(MIN)}$ is from the *Electrical Characteristics*, and K (1/f_{SW}) is taken from Table 3. The absolute minimum input voltage is calculated with h = 1.

If the calculated $V_{IN(MIN)}$ is greater than the required minimum input voltage, operating frequency must be reduced or output capacitance added to obtain an acceptable VSAG. If operation near dropout is anticipated, calculate VSAG to be sure of adequate transient response.

Dropout Design Example:

 $V_{OUT2} = 2.5V$

 $f_{SW} = 355kHz$

 $K = 3.0\mu s$, worst-case $K_{MIN} = 3.3\mu s$

toff(MIN) = 500ns

V_CHG = 100mV

h = 1.5:

$$V_{\text{IN(MIN)}} = \frac{2.5V + 0.1V}{1 - \left(\frac{1.5 \times 500 \text{ns}}{3.0 \mu \text{s}}\right)} = 3.47V$$

Calculating again with h = 1 and the typical K-factor value ($K = 3.3\mu$ s) gives the absolute limit of dropout:

$$V_{IN(MIN)} = \frac{2.5V + 0.1V}{1 - \left(\frac{1 \times 500 \text{ns}}{3.3 \mu \text{s}}\right)} = 3.06V$$

Therefore, V_{IN(MIN)} must be greater than 3.06V, even with very large output capacitance, and a practical input voltage with reasonable output capacitance would be 3.47V.

PCB Layout Guidelines

Careful PCB layout is critical to achieving low switching losses and clean, stable operation. The switching power stage requires particular attention. If possible, mount all the power components on the top side of the board, with their ground terminals flush against one another. Follow these guidelines for good PCB layout:

- Keep the high-current paths short, especially at the ground terminals. This practice is essential for stable, jitter-free operation.
- Keep the power traces and load connections short.
 This practice is essential for high efficiency. Using thick copper PCBs (2oz vs. 1oz) can enhance full-load efficiency by 1% or more. Correctly routing PCB traces is a difficult task that must be approached in terms of fractions of centimeters, where a single milliohm of excess trace resistance causes a measurable efficiency penalty.
- Minimize current-sensing errors by connecting LX_ directly to the drain of the low-side MOSFET.
- When trade-offs in trace lengths must be made, it is preferable to allow the inductor charging path to be made longer than the discharge path. For example, it is better to allow some extra distance between the input capacitors and the high-side MOSFET than to

- allow distance between the inductor and the lowside MOSFET or between the inductor and the output filter capacitor.
- Route high-speed switching nodes (BST_, LX_, DH_, and DL_) away from sensitive analog areas (REF, FB , and OUT).

A sample layout is available in the MAX17101 evaluation kit data sheet.

Layout Procedure

- Place the power components first, with ground terminals adjacent (N_L source, C_{IN}, C_{OUT}, and D_L anode). If possible, make all these connections on the top layer with wide, copper-filled areas.
- 2) Mount the controller IC adjacent to the low-side MOSFET, preferably on the back side opposite N_L and N_H to keep LX_, GND, DH_, and the DL_ gatedrive lines short and wide. The DL_ and DH_ gate traces must be short and wide (50 mils to 100 mils wide if the MOSFET is 1in from the controller IC) to keep the driver impedance low and for proper adaptive dead-time sensing.
- 3) Group the gate-drive components (BST_ capacitor, VDD bypass capacitor) together near the controller IC.
- 4) Make the DC-DC controller ground connections as shown in Figure 1. This diagram can be viewed as having two separate ground planes: power ground, where all the high-power components go; and an analog ground plane for sensitive analog components. The analog ground plane and power ground plane must meet only at a single point directly at the IC.
- 5) Connect the output power planes directly to the output filter capacitor positive and negative terminals with multiple vias. Place the entire DC-DC converter circuit as close to the load as is practical.

Table 5. MAX17101 vs. MAX8778 Design Differences

MAX17101	MAX8778
RTC power-up required for controller operation.	LDO and switching regulators independent of RTC operation.
LDO does not support 0.3V ~ 2V adjustable output; LDO is preset to 5V or 3.3V.	LDO external reference input for 0.3V ~ 2V adjustable output in addition to preset 5V or 3.3V.

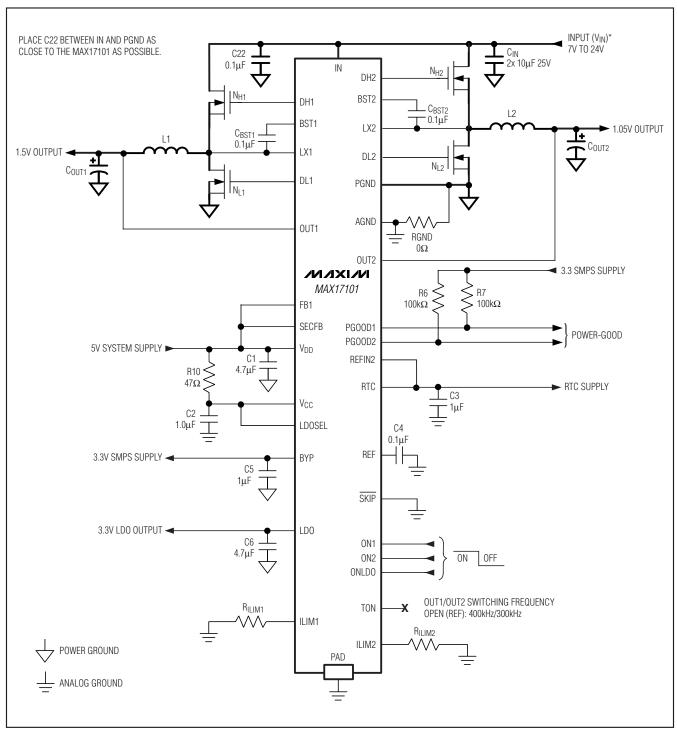


Figure 5. Standard Output Application Circuit—Chipset Supply

PROCESS: BICMOS

Dual Quick-PWM, Step-Down Controller with Low-Power LDO, RTC Regulator

_Chip Information

Package Information

For the latest package outline information and land patterns, go to www.maxim-ic.com/packages.

PACKAGE TYPE	PACKAGE CODE	DOCUMENT NO.
32 TQFN-EP	T3255-3	21-0140

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